mail

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RF Power LDMOS Transistors

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

These RF power devices are designed for pulse applications operating at frequencies from 1200 to 1400 MHz. The devices are suitable for use in pulse applications and are ideal for use in high power military and commercial L-Band radar applications.

Typical Short Pulse Performance: In 1200–1400 MHz reference circuit, V_{DD} = 52 Vdc, $I_{DQ(A+B)}$ = 100 mA

Frequency (MHz)	Signal Type	P _{out} (W)	G _{ps} (dB)	η _D (%)
1200	Pulse	1130 Peak	15.5	47.5
1300	(128 μsec, 10% Duty Cycle)	1170 Peak	17.2	47.0
1400		1000 Peak	17.0	46.5

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage	Result
1400	Pulse (128 μsec, 10% Duty Cycle)	> 20:1 at All Phase Angles	31.6 Peak (3 dB Overdrive)	52	No Device Degradation

Features

- · Internally input and output matched for broadband operation and ease of use
- Device can be used in a single-ended, push-pull or quadrature configuration
- Qualified up to a maximum of 52 V_{DD} operation
- High ruggedness, handles > 20:1 VSWR
- Integrated ESD protection with greater negative voltage range for improved Class C operation and gate voltage pulsing
- Characterized with series equivalent large-signal impedance parameters

Typical Applications

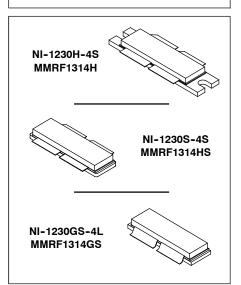
• Military and commercial L-Band radar systems

Document Number: MMRF1314H Rev. 0, 3/2016

VRoHS

MMRF1314H MMRF1314HS MMRF1314GS

1200–1400 MHz, 1000 W PEAK, 52 V AIRFAST RF POWER LDMOS TRANSISTORS



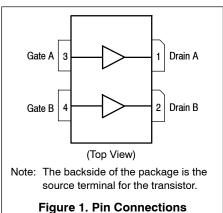




Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +105	Vdc
Gate-Source Voltage	V _{GS}	-6.0, +10	Vdc
Storage Temperature Range	T _{stg}	−65 to +150	°C
Case Operating Temperature Range	T _C	-40 to +150	°C
Operating Junction Temperature Range (1)	TJ	-40 to +225	°C
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	909 4.55	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value ⁽²⁾	Unit
Thermal Impedance, Junction to Case Case Temperature 60°C, 1000 W Peak, 128 μsec Pulse Width, 10% Duty Cycle, 50 Vdc, I _{DQ(A+B)} = 100 mA, 1400 MHz	$Z_{\theta JC}$	0.018	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2500 V
Machine Model (per EIA/JESD22-A115)	B, passes 200 V
Charge Device Model (per JESD22-C101)	IV, passes 2000 V

Table 4. Electrical Characteristics ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics ⁽³⁾					
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	_	1	μAdc
Drain-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = 10 μAdc)	V _{(BR)DSS}	105			Vdc
Zero Gate Voltage Drain Leakage Current $(V_{DS} = 50 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$	I _{DSS}			1	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 105 Vdc, V _{GS} = 0 Vdc)	I _{DSS}			10	μAdc
On Characteristics					
Gate Threshold Voltage ⁽³⁾ (V _{DS} = 10 Vdc, I _D = 520 μAdc)	V _{GS(th)}	1.3	1.8	2.3	Vdc

(V _{DS} = 10 Vdc, I _D = 520 µAdc)	()				
Gate Quiescent Voltage (4) (V_{DD} = 50 Vdc, $I_{DQ(A+B)}$ = 100 mAdc, Measured in Functional Test)	V _{GS(Q)}	1.6	2.1	2.6	Vdc
Drain-Source On-Voltage ⁽³⁾ (V _{GS} = 10 Vdc, I _D = 2.6 Adc)	V _{DS(on)}	0.05	0.16	0.35	Vdc

Dynamic Characteristics (3)

Reverse Transfer Capacitance	C _{rss}	—	2.98	—	pF
(V _{DS} = 50 Vdc \pm 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)					

1. Continuous use at maximum temperature will affect MTTF.

2. Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to http://www.nxp.com/RF and search for AN1955.

3. Each side of device measured separately.

4. Measurement made with device in push-pull configuration.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) (continued)

	Characteristic	Symbol	Min	Тур	Мах	Unit
--	----------------	--------	-----	-----	-----	------

Functional Tests ^(1,2) (In Freescale Narrowband Production Test Fixture, 50 ohm system) $V_{DD} = 50$ Vdc, $I_{DQ(A+B)} = 100$ mA, $P_{out} = 1000$ W Peak (100 W Avg.), f = 1400 MHz, 128 µsec Pulse Width, 10% Duty Cycle

Power Gain	G _{ps}	16.0	17.7	19.5	dB
Drain Efficiency	η _D	46.0	52.1	—	%
Input Return Loss	IRL	_	-18	-9	dB

Load Mismatch/Ruggedness (In Freescale Narrowband Test Fixture, 50 ohm system) I_{DQ(A+B)} = 100 mA

Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage, V _{DD}	Result
1400	Pulse (128 μsec, 10% Duty Cycle)	> 20:1 at all Phase Angles	31.6 Peak (3 dB Overdrive)	52	No Device Degradation

Table 5. Ordering Information

Device	Tape and Reel Information	Package
MMRF1314HR5		NI-1230H-4S, Eared
MMRF1314HSR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	NI-1230S-4S, Earless
MMRF1314GSR5		NI-1230GS-4L, Gull Wing

1. Measurement made with device in push-pull configuration.

2. Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GS) parts.

TYPICAL CHARACTERISTICS

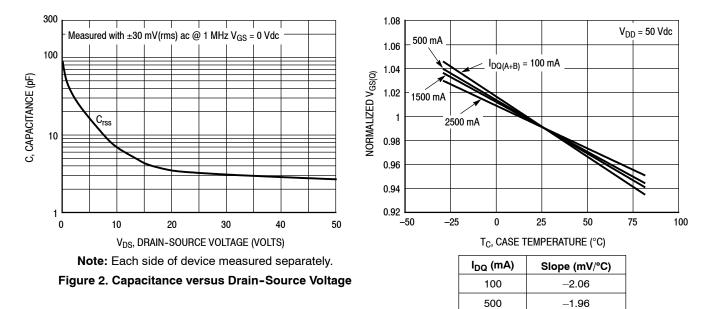


Figure 3. Normalized V_{GS} versus Quiescent Current and Case Temperature

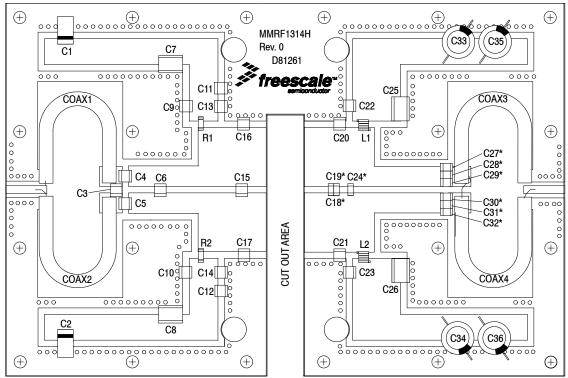
-1.94

-1.72

1500

2500

1400 MHz NARROWBAND PRODUCTION TEST FIXTURE — 4.0" × 6.0" (10.2 cm × 15.2 cm)

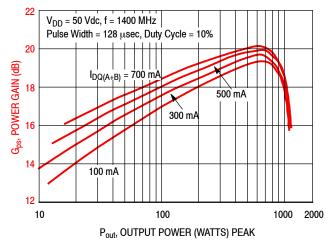


* C18, C19, C24, C27, C28, C29, C30, C31 and C32 are mounted vertically.

Part	Description	Part Number	Manufacturer
C1, C2	22 μ F, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C3	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C4, C5, C9, C10, C13, C14, C22, C23	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C6	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C7, C8	2.2 µF Chip Capacitors	C1825C225J5RACTU	Kemet
C11, C12	0.1 μF Chip Capacitors	CDR33BX104AKY9S	AVX
C15	2.2 pF Chip Capacitor	ATC100B2R2BT500XT	ATC
C16, C17	0.7 pF Chip Capacitors	ATC100B0R7BT500XT	ATC
C18	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C19	1.2 pF Chip Capacitor	ATC100B1R2BT500XT	ATC
C20, C21	2.2 pF Chip Capacitors	ATC100B2R2BT500XT	ATC
C24	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C25, C26	0.01 μF Chip Capacitors	C1825C103K1GACTU	Kemet
C27, C28, C29, C30, C31, C32	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C33, C34, C35, C36	470 μ F, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
Coax1, Coax2, Coax3, Coax4	$35 \ \Omega$ Semi Rigid Coax 1.454" Shield Length	HSF-141-35-C	Hongsen Cable
L1, L2	17.5 nH, 4 Turn Inductors	GA3095-ALC	Coilcraft
R1, R2	100 Ω , 1 W Chip Resistors	CRCW2512100RFKEG	Vishay
PCB	Arlon AD255A, 0.03", $\epsilon_r = 2.55$	D81261	MTL

TYPICAL CHARACTERISTICS — 1400 MHz PRODUCTION TEST FIXTURE







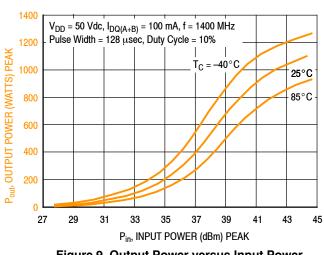


Figure 9. Output Power versus Input Power

MMRF1314H MMRF1314HS MMRF1314GS

Figure 6. Output Power versus Input Power

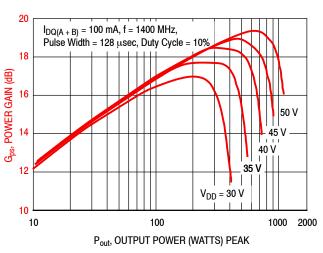
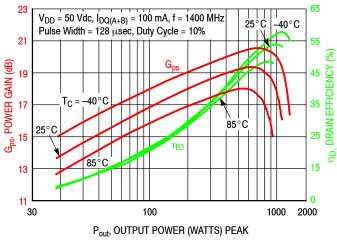
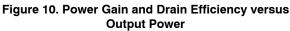


Figure 8. Power Gain versus Output Power





1400 MHz NARROWBAND PRODUCTION TEST FIXTURE

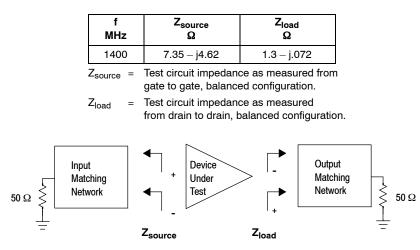
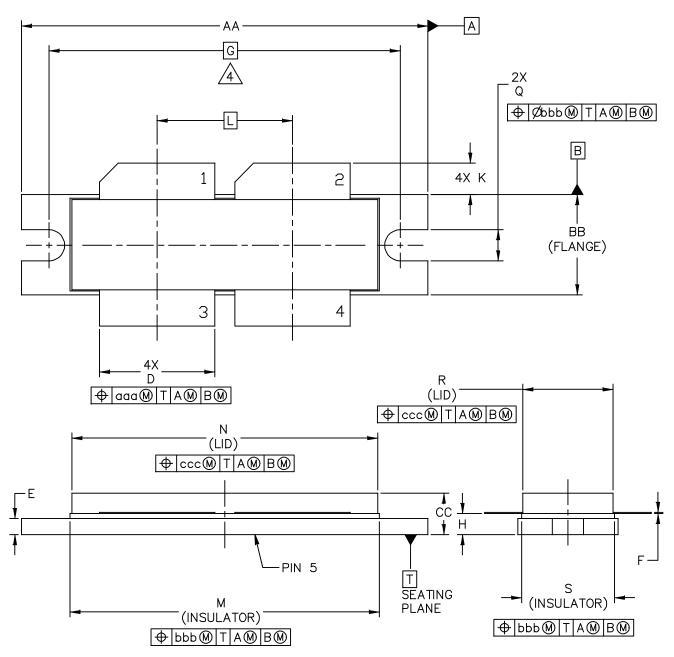


Figure 11. Narrowband Series Equivalent Source and Load Impedance — 1400 MHz

PACKAGE DIMENSIONS



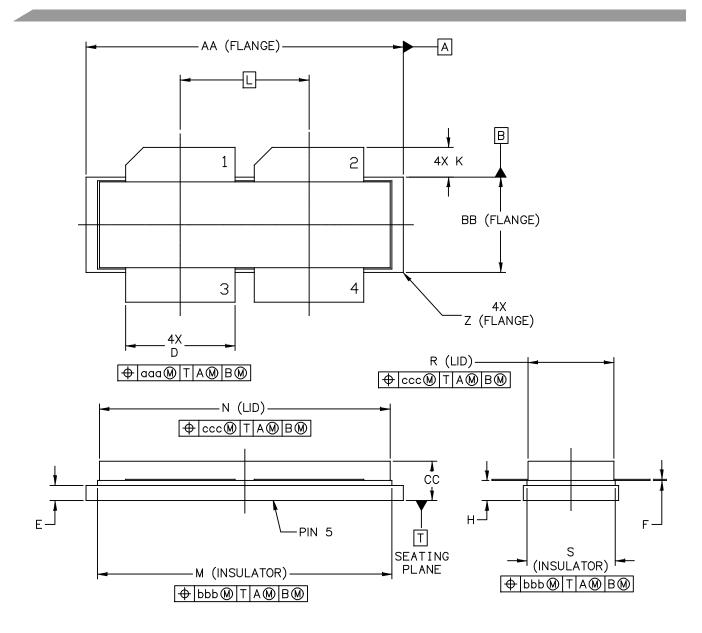
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TITLE:		DOCUME	NT NO: 98ASB16977C	REV: F
NI-1230-4H		STANDAF	RD: NON-JEDEC	
			28	FEB 2013

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14. 5M-1994.
- 2. CONTROLLING DIMENSION: INCH
- 3. DIMENSION H IS MEASURED . 030 INCH (0. 762 MM) AWAY FROM PACKAGE BODY.

 $\frac{4}{4}$ RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

	IN	СН	MILI	LIMETER			INCH	MILLIN	IETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
AA	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55
BB	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.30
СС	.170	.190	4.32	4.83	R	.355	.365	9.02	9.27
D	.455	.465	11.56	11.81	S	.365	.375	9.27	9.53
Е	.062	.066	1.57	1.68					
F	.004	.007	0.10	0.18					
G	1.400	BSC	35.	56 BSC	aaa	.013 0.33		33	
Н	.082	.090	2.08	2.29	bbb		.010	0.:	25
К	.117	.137	2.97	3.48	ccc		.020	0.	51
L	.540	BSC	13.	72 BSC					
М	1.219	1.241	30.96	31.52					
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	NI-1230-4H					STANDARD: NON-JEDEC			
					28 FEB 2013				

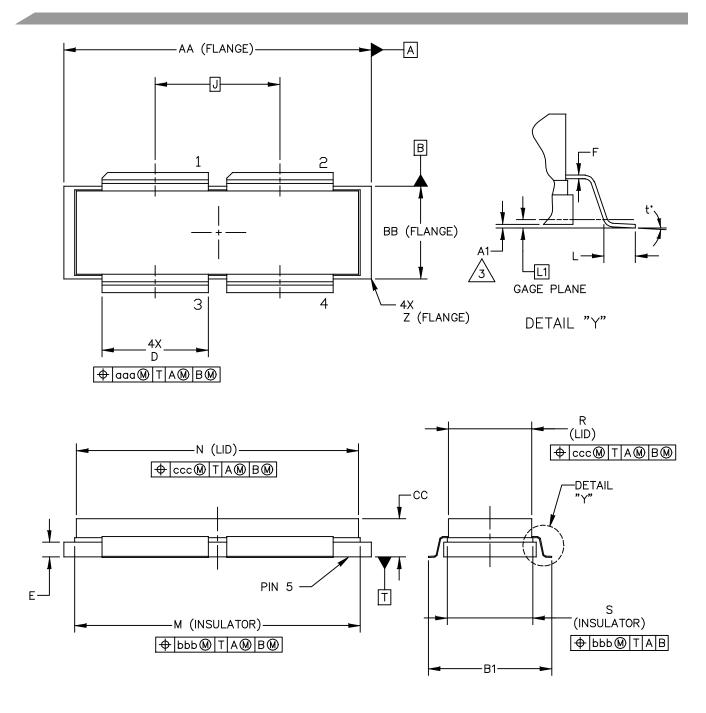


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		S0T1829	9—1	19 FEB 2016

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH
- 3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY

	INC	INCHES		MILLIMETERS		IN	ICHES	MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX	
AA	1.265	1.275	32.13	32.39	R	.355	.365	9.02	9.27	
BB	.395	.405	10.03	10.29	S	.365	.375	9.27	9.53	
cc	.170	.190	4.32	4.83	Z	R.000	R.040	R0.00	R1.02	
D	.455	.465	11.56	11.81						
E	.062	.066	1.57	1.68	aaa		.013	0.	33	
F	.004	.007	0.10	0.18	bbb		.010	0.25		
н	.082	.090	2.08	2.29	ccc	.020		.020 0.51		
к	.117	.137	2.97	3.48						
L	.540	BSC	13	.72 BSC						
М	1.219	1.241	30.96	31.52						
N	1.218	1.242	30.94	31.55						
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		NI-1230)—4S			STANDARD: NON-JEDEC				
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TITLE:		DOCUMEN	NT NO: 98ASA00459D	REV: B
NI-1230-45 GU	STANDARD: NON-JEDEC			
		S0T1806	5–2	23 FEB 2016

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH

3. DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM T. THE POSITIVE VALUE IMPLIES THAT THE PACKAGE BOTTOM IS HIGHER THAN THE LEAD BOTTOM.

	INC	CHES MILLIMETERS			IN	ICHES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
AA	1.265	1.275	32.13	32.39	R	.355	.365	9.02	9.27
A1	001	.011	-0.03	0.28	S	.365	.375	9.27	9.53
BB	.395	.405	10.03	10.29	Z	R.000	R.040	R0.00	R1.02
B1	.564	.574	14.32	14.58	ť	0.	8.	0.	8'
cc	.170	.190	4.32	4.83					
D	.455	.465	11.56	11.81	aaa		.013	0.33	
E	.062	.066	1.57	1.68	bbb		.010	0.25	
F	.004	.007	0.10	0.18	ccc		.020	0.51	
J	.540	BSC	13.	72 BSC					
L	.038	.046	0.97	1.17					
L1	.01	BSC	0.	25 BSC					
м	1.219	1.241	30.96	31.52					
N	1.218	1.242	30.94	31.55					
C		NXP SEMICONDUCTORS N.V. ALL RIGHTS RESERVED			L OUT	LINE	PRINT VEF	SION NOT	TO SCALE
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	Ν	II—1230—	-4S GL	JLL		STANDARD: NON-JEDEC			
						SOT1806	-2	23	3 FEB 2016

PRODUCT DOCUMENTATION

Refer to the following resources to aid your design process.

Application Notes

- · AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

EB212: Using Data Sheet Impedances for RF LDMOS Devices

To Download Resources Specific to a Given Part Number:

- 1. Go to http://www.nxp.com/RF
- 2. Search by part number
- 3. Click part number link
- 4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description			
0	Mar. 2016	Initial Release of Data Sheet			

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